Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
09/828,202	SHIEH, JIA-HORNG
Examiner	Art Unit
Esaw T. Abraham	2133

SEARCHED			
Class	Subclass	Date	Examiner
714	784, 785, 786, 793	7/12/2005	EA
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INTERFERENCE SEARCHED			
Subclass	Date	Examiner	
793, 785	7/12/2005	EA	
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	Subclass 793, 785	Subclass Date 793, 785 7/12/2005	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
IEEE and inventor's search was conducted for double patenting. No double patent issue was found.	7/12/2005	EΑ
East (USPT, EPO, JPO, derwent, PGPUB), 714/785,793 (for text only) See search history printout.	7/15/2002	EA
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